

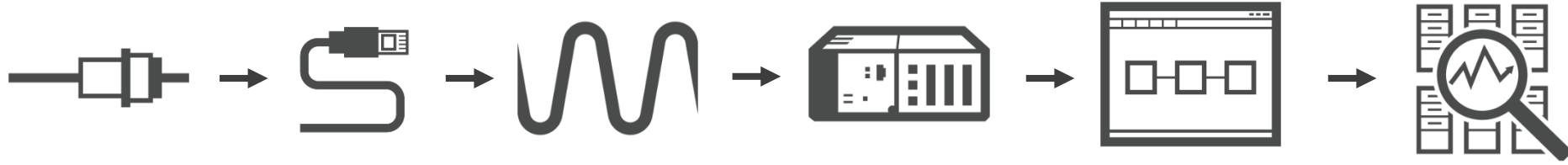


ENGINEER  
NEXT

NIDays

The image features a background of diagonal stripes in various shades of blue, green, orange, and red. The text 'ENGINEER NEXT' is prominently displayed in white, with 'ENGINEER' in a smaller font above 'NEXT'. A yellow geometric shape, resembling a stylized 'N' or a folded ribbon, is integrated into the 'X' of 'NEXT'. To the left of 'NEXT', the word 'NIDays' is enclosed in a white rectangular box, tilted to match the angle of the main text.

# Practical Advice for Building a DAQ System

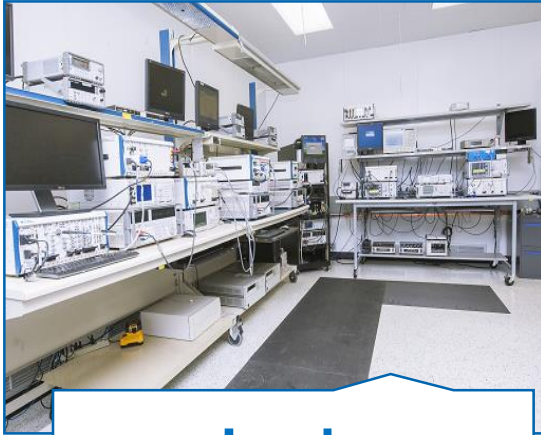


## Topics to Cover

- What is a DAQ System?
- What is the Purpose of a DAQ System?
- Elements of a DAQ System
- Now You're Ready!

# What is a DAQ System?

Data acquisition (DAQ) is the process of measuring an electrical or physical phenomenon such as voltage, current, temperature, pressure, or sound with an acquisition device. A DAQ system consists of many elements from the sensor to the data analysis



Lab



Test Cell

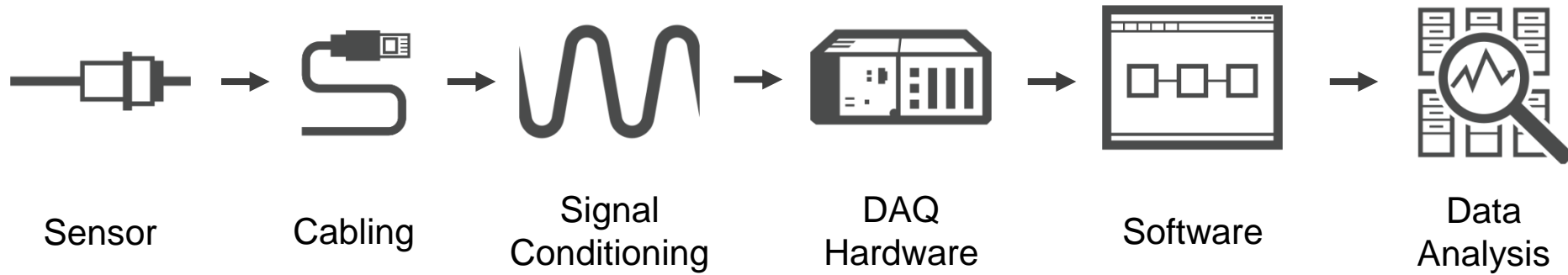


Structural

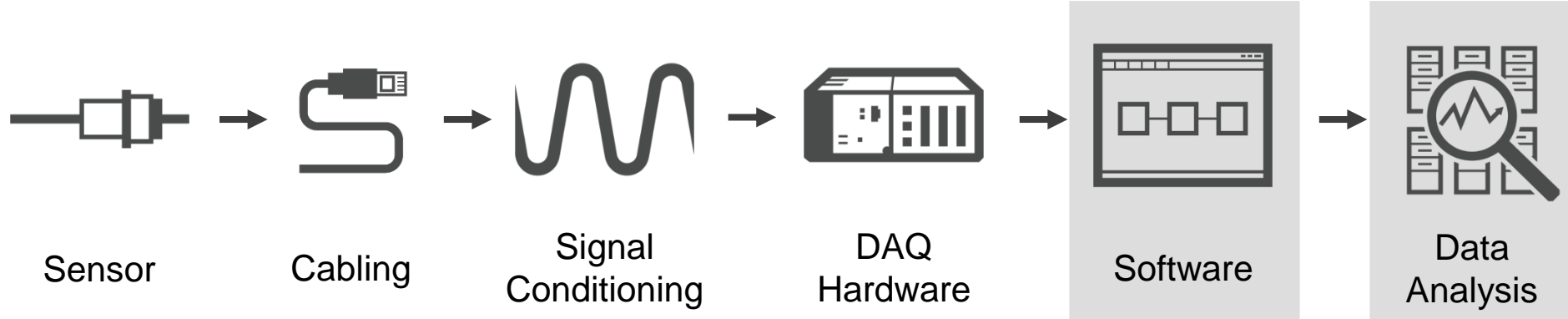
# What is the Purpose of DAQ System?

Research & Analysis	Characterizing and logging behaviors or properties
Design Validation & Verification	Testing adherence to an industry standard
Manufacturing & Quality Test	Performing functional and system-level product test
Diagnostics and Repair	Manual and ad-hoc troubleshooting
Asset Condition Monitoring	Long-term, continuous monitoring of equipment
PC-based Control & Automation	Performing open-loop and closed-loop control, such as PID

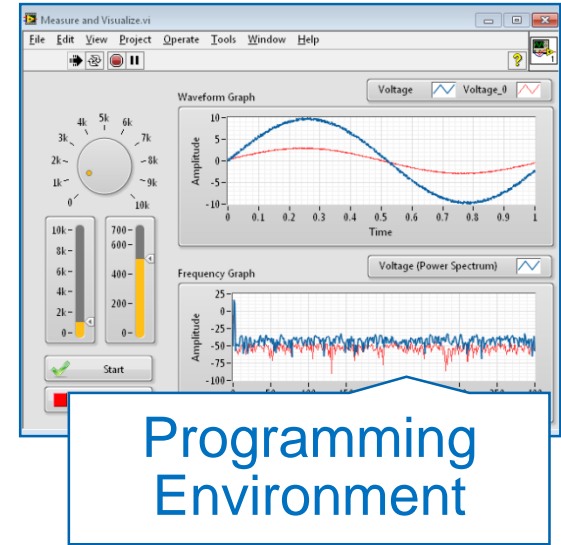
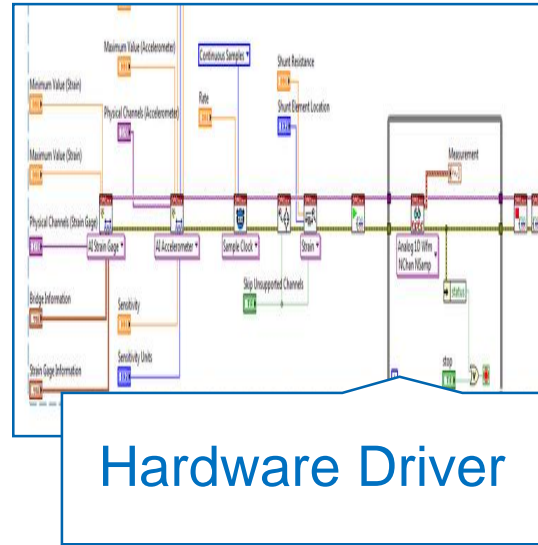
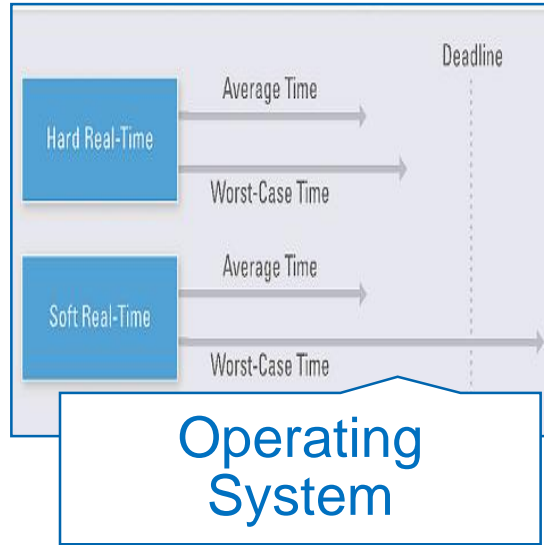
# Elements of a DAQ System



# Elements of a DAQ System

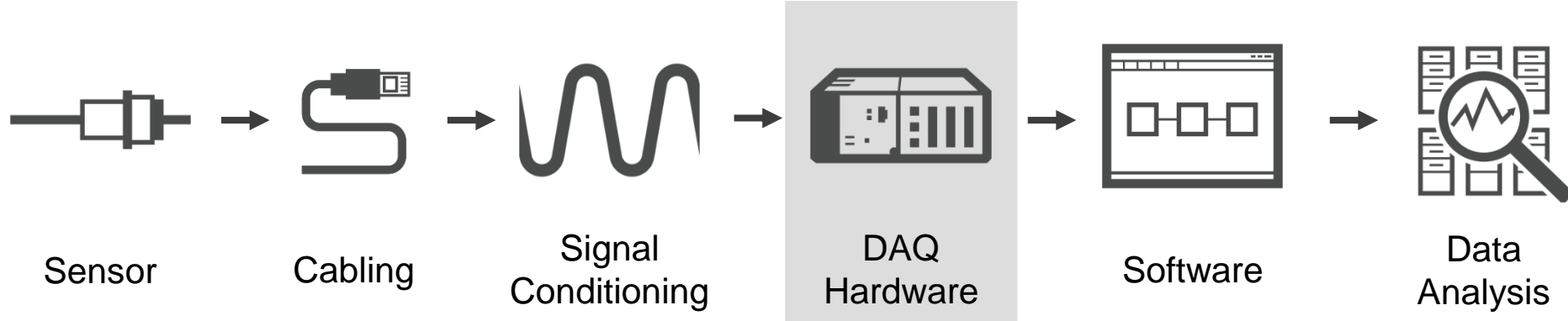


# What Software Do I Use?



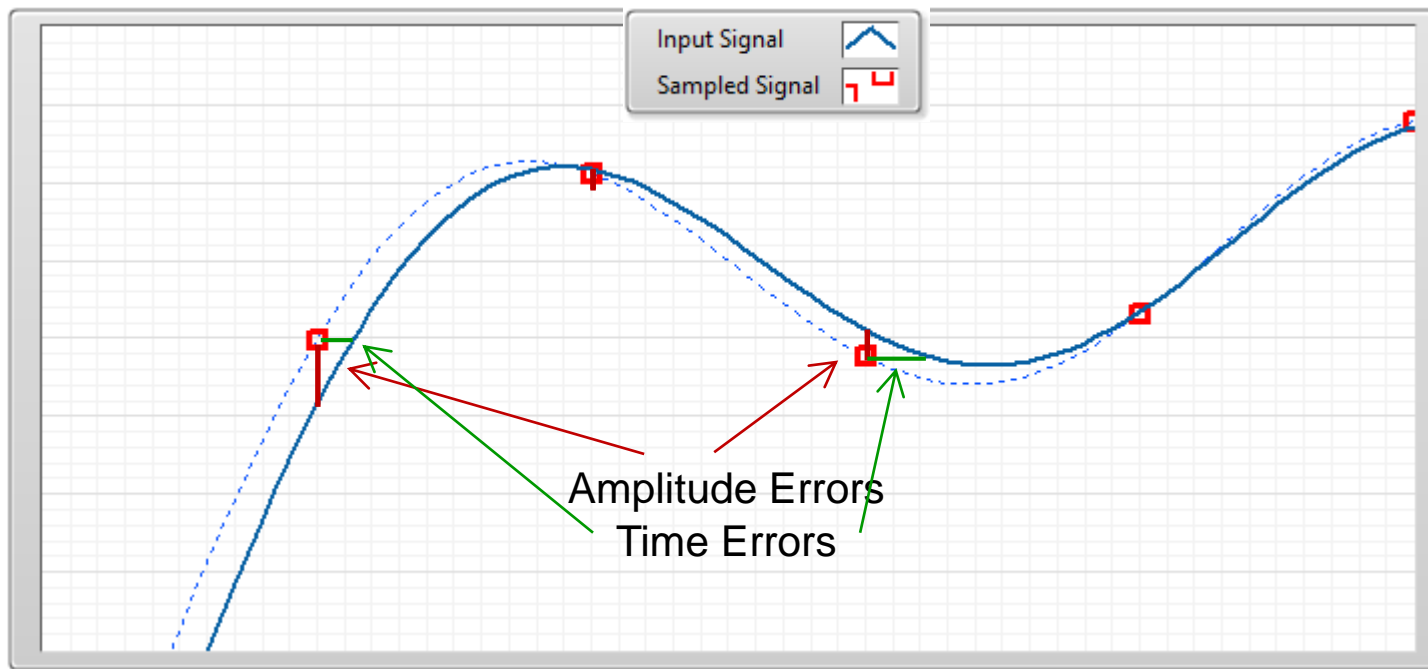


# Elements of a DAQ System



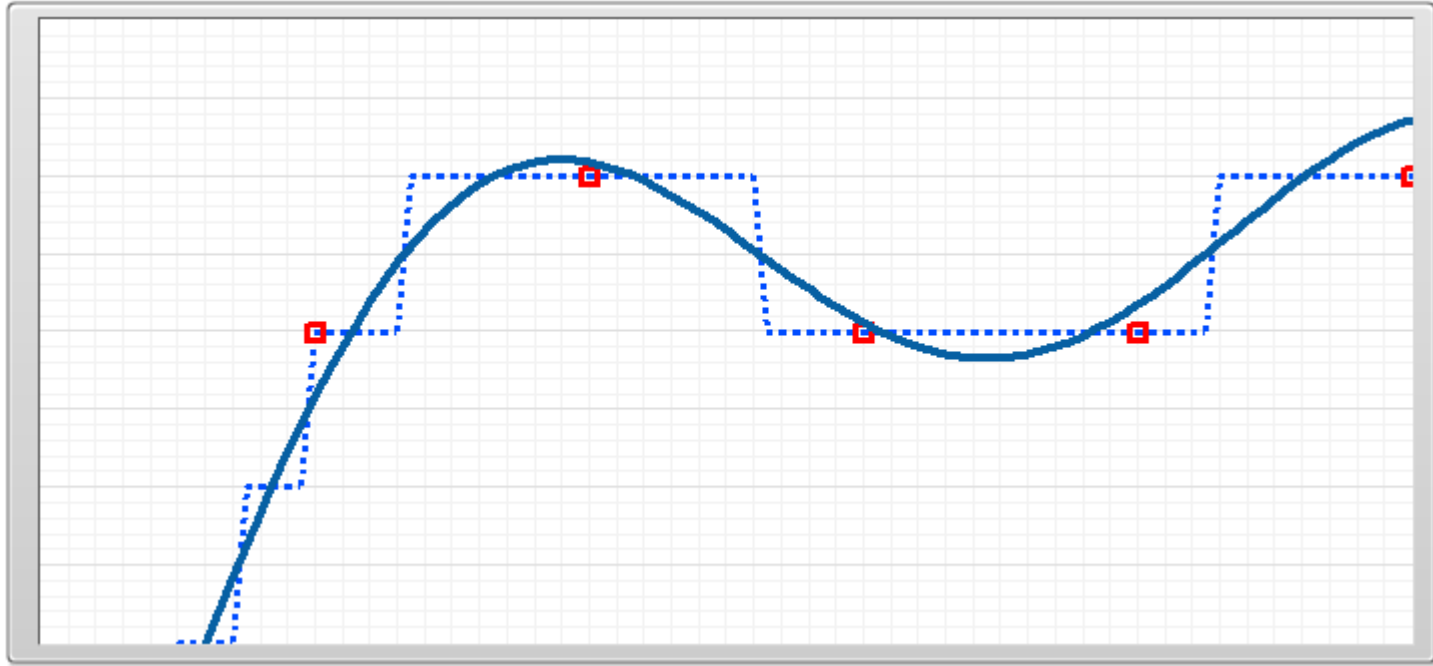
# Data Acquisition Hardware

Acquiring one or more measurements in both amplitude and time



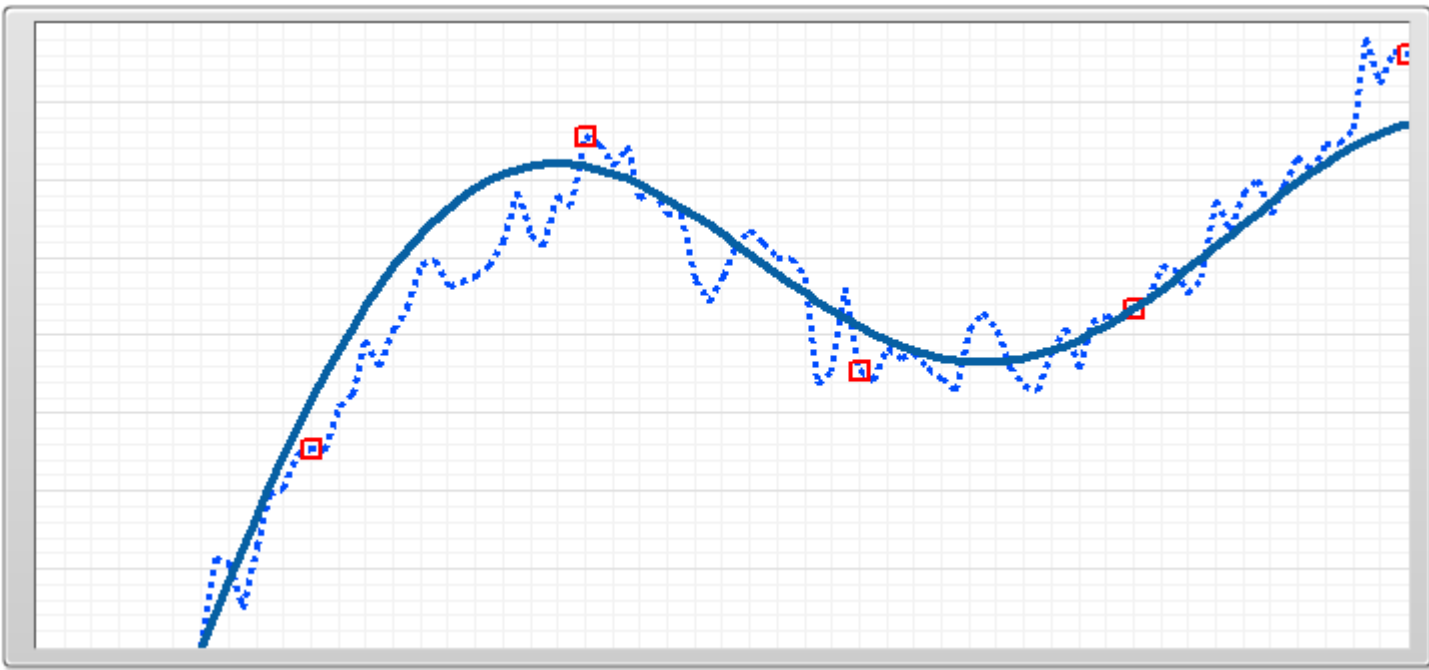
# Measurement Resolution

Limited by quantization error (number of bits)



# Measurement Resolution

Also limited by noise



# Resolution and Gain

- RESOLUTION limits your measurements' PRECISION
- Both quantization error ("bits") and noise impact resolution
- Example: 16-bit PXI-6361
  - Noise dictates resolution at high gains

Gain	Input Range	Bit Size	Random Noise
1	$\pm 10\text{V}$	300 $\mu\text{V}$	315 $\mu\text{V}_{\text{rms}}$
2	$\pm 5\text{V}$	150 $\mu\text{V}$	157 $\mu\text{V}_{\text{rms}}$
5	$\pm 2\text{V}$	60 $\mu\text{V}$	64 $\mu\text{V}_{\text{rms}}$
10	$\pm 1\text{V}$	30 $\mu\text{V}$	38 $\mu\text{V}_{\text{rms}}$
20	$\pm 0.5\text{V}$	15 $\mu\text{V}$	27 $\mu\text{V}_{\text{rms}}$
50	$\pm 0.2\text{V}$	6 $\mu\text{V}$	21 $\mu\text{V}_{\text{rms}}$
100	$\pm 0.1\text{V}$	3 $\mu\text{V}$	17 $\mu\text{V}_{\text{rms}}$

# Resolution and Gain

- RESOLUTION limits your measurements' PRECISION
- Both quantization error ("bits") and noise impact resolution
- Example: 16-bit PXI-6361
  - Noise dictates resolution at high gains
- Another Example: 24-bit NI 9251
  - Only has a single gain-
  - Only needs a single gain!

Gain	Input Range	Bit Size	Random Noise
1	$\pm 10\text{V}$	$300\ \mu\text{V}$	$315\ \mu\text{V}_{\text{rms}}$
2	$\pm 5\text{V}$	$150\ \mu\text{V}$	$157\ \mu\text{V}_{\text{rms}}$
5	$\pm 2\text{V}$	$60\ \mu\text{V}$	$64\ \mu\text{V}_{\text{rms}}$
10	$\pm 1\text{V}$	$30\ \mu\text{V}$	$38\ \mu\text{V}_{\text{rms}}$
20	$\pm 0.5\text{V}$	$15\ \mu\text{V}$	$27\ \mu\text{V}_{\text{rms}}$
50	$\pm 0.2\text{V}$	$6\ \mu\text{V}$	$21\ \mu\text{V}_{\text{rms}}$
100	$\pm 0.1\text{V}$	$3\ \mu\text{V}$	$17\ \mu\text{V}_{\text{rms}}$
		NI 9251	
1	$\pm 4.25\text{V}$	$0.5\ \mu\text{V}$	$9\ \mu\text{V}_{\text{rms}}$

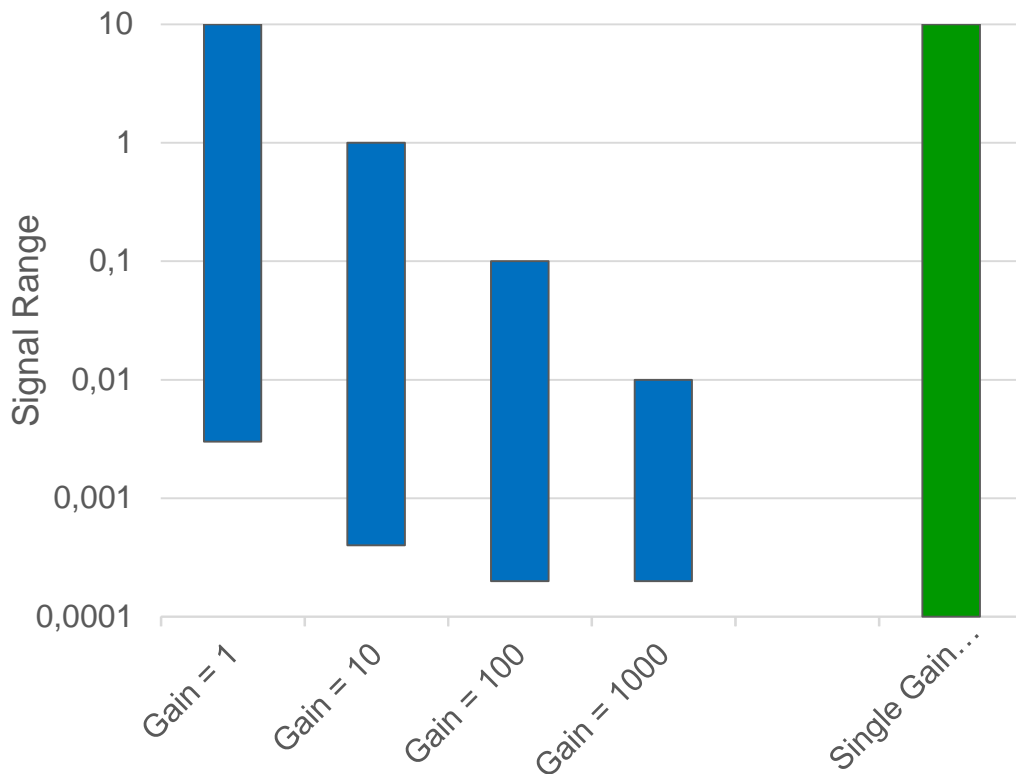
# Programmable gain is a crutch for limited resolution

## MYTH

- “Use gain to match the input range to the signal range, or else you are throwing away resolution”

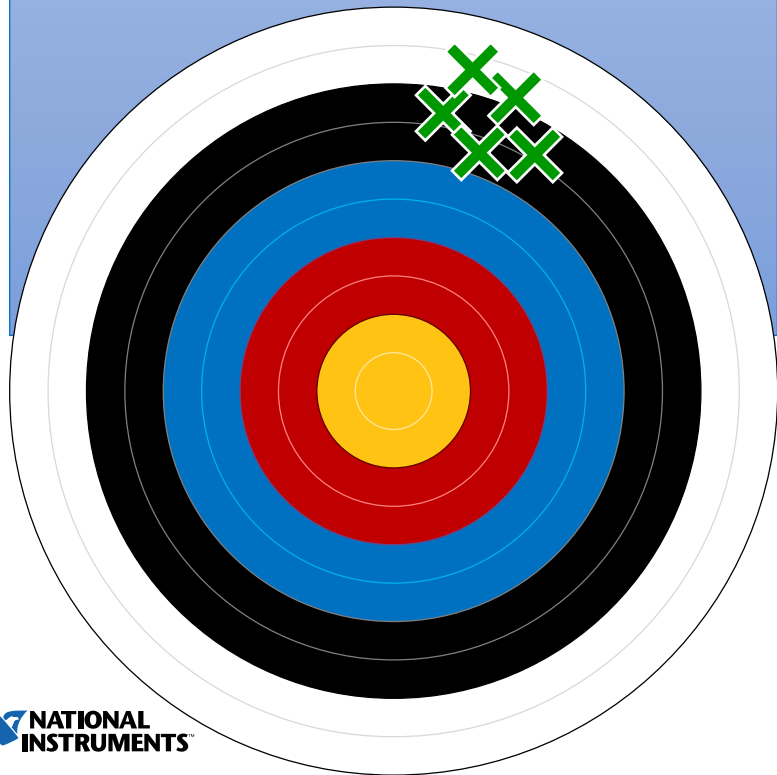
## REALITY

- Choose your DAQ Hardware to have enough resolution for your application, resorting to gain that limits your range only if necessary

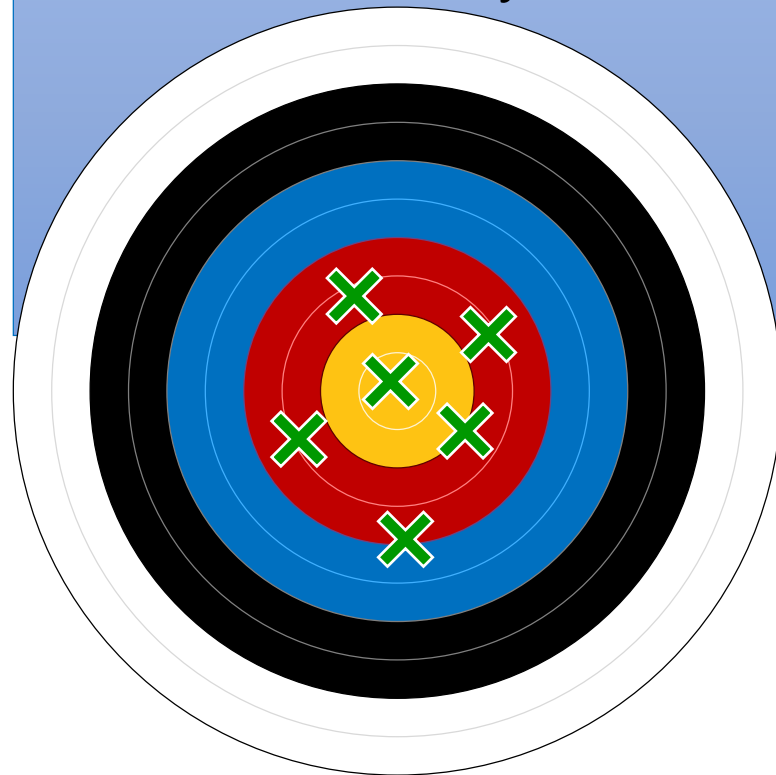


# Resolution vs Accuracy

Precision/Resolution



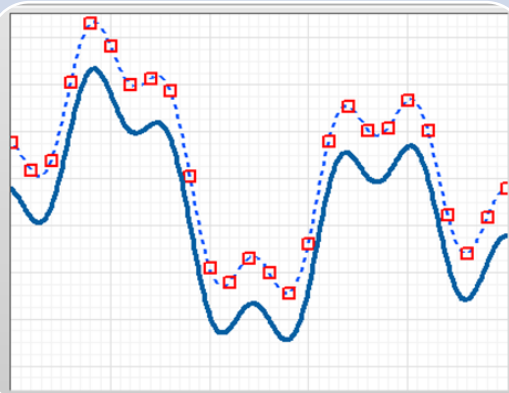
Accuracy





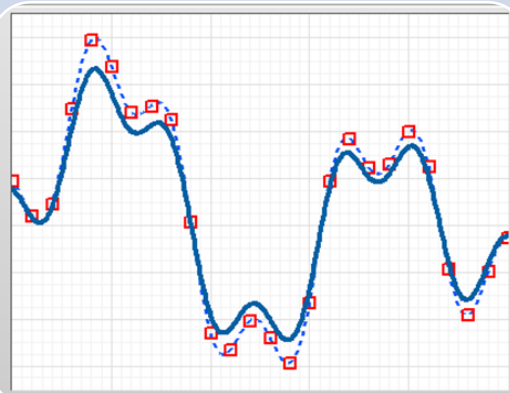
# Different Types of Error Combine to Limit Accuracy

Your application may be more sensitive to one form of error than to others



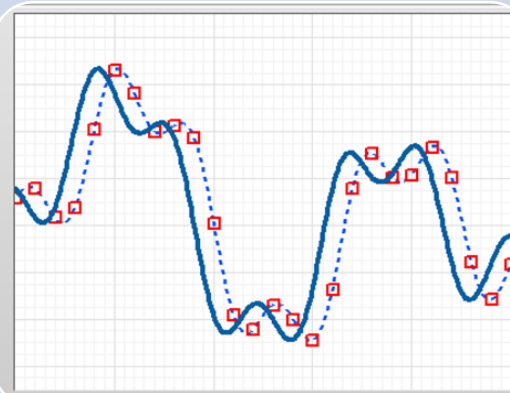
## Offset Error

- Shifts readings by constant value



## Gain Error

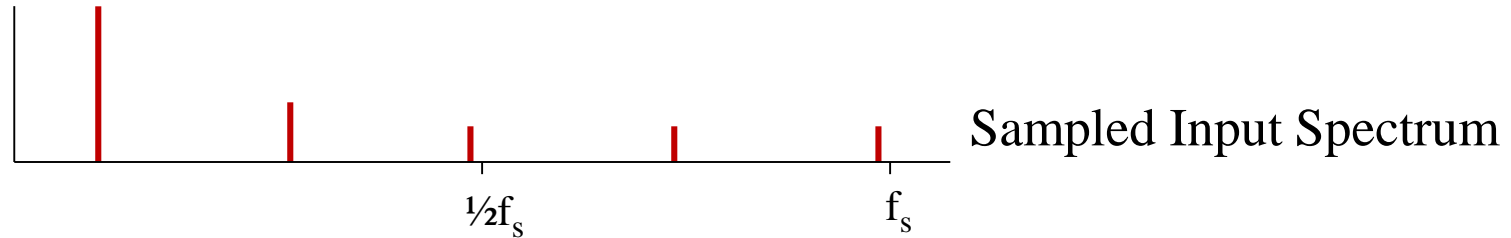
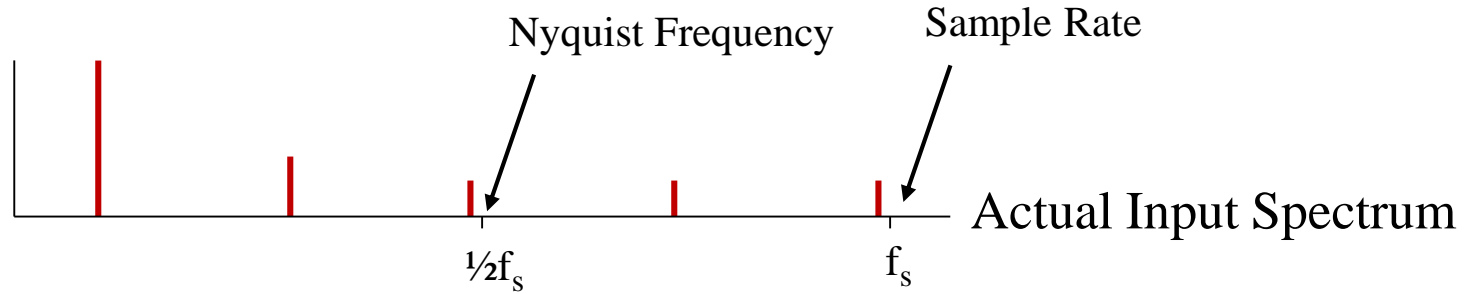
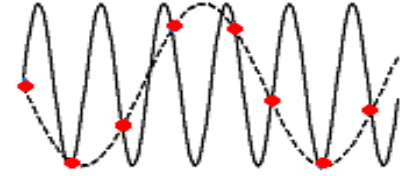
- Scales readings proportionally



## Delay (Latency)

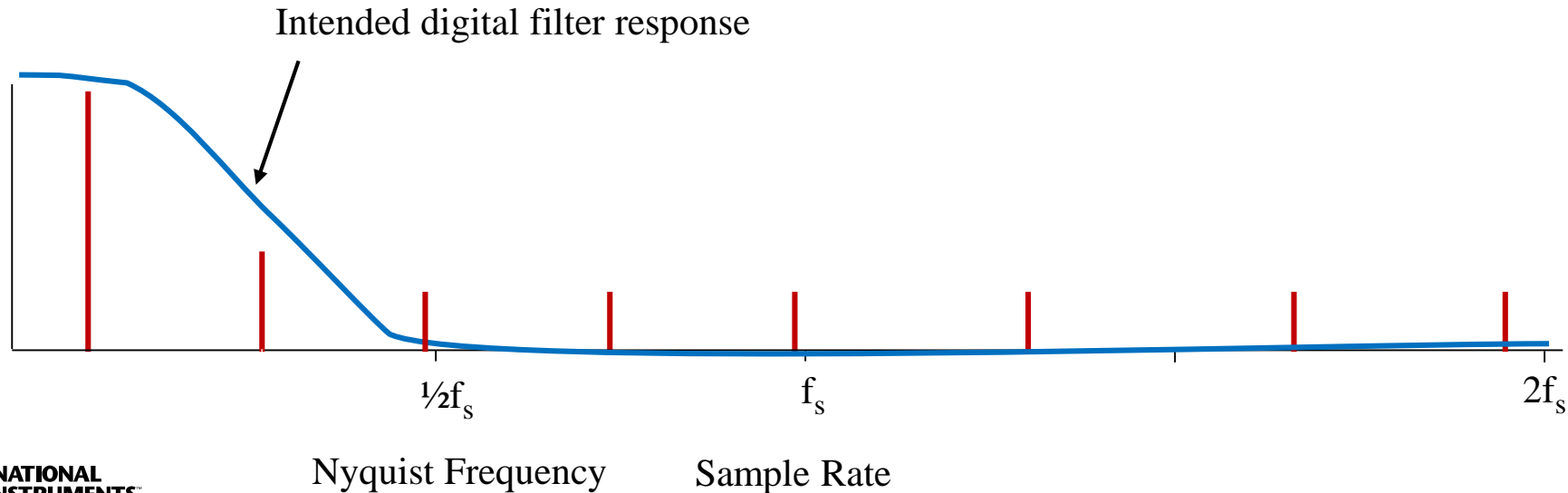
- Shifts readings in time

# Aliasing from Sampling



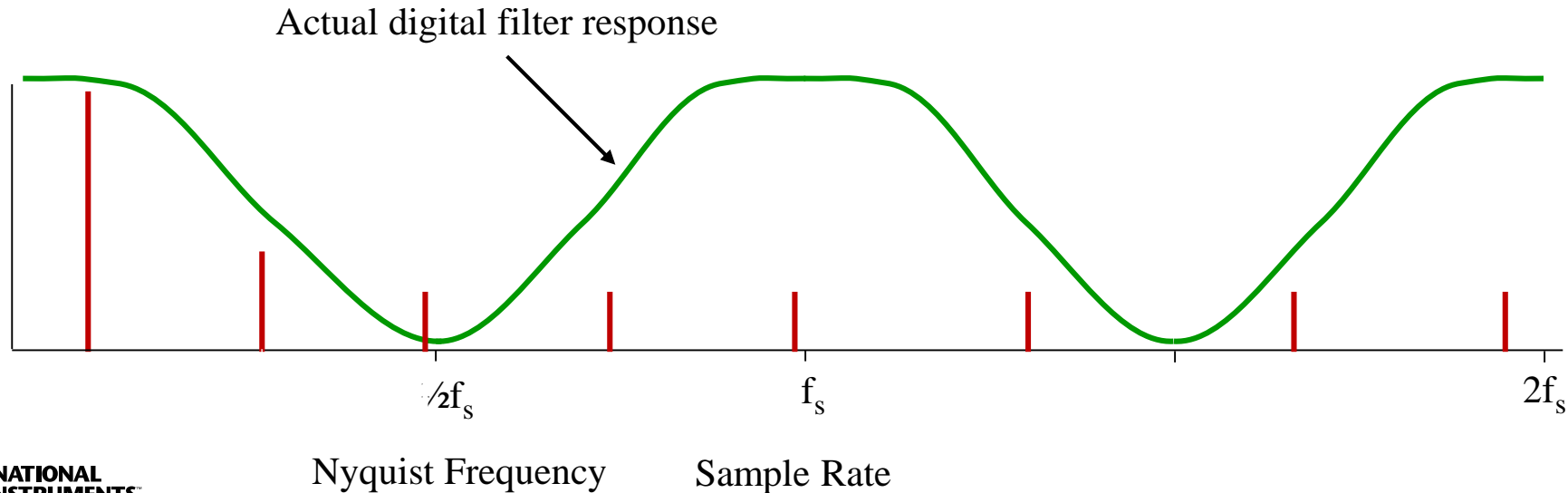
# Anti-Aliasing before Software Digital Filtering

- Digital filtering of sampled data can have unexpected results



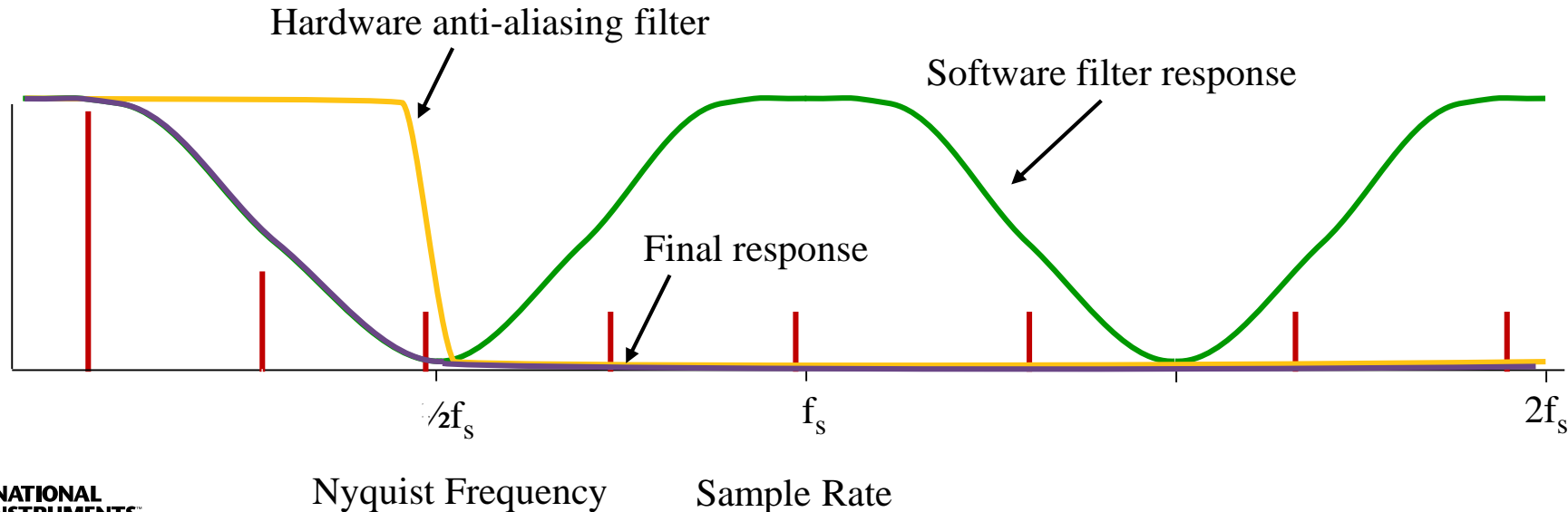
# Anti-Aliasing before Software Digital Filtering

- Digital filtering of sampled data can have unexpected results
- Actual filter response is aliased as well

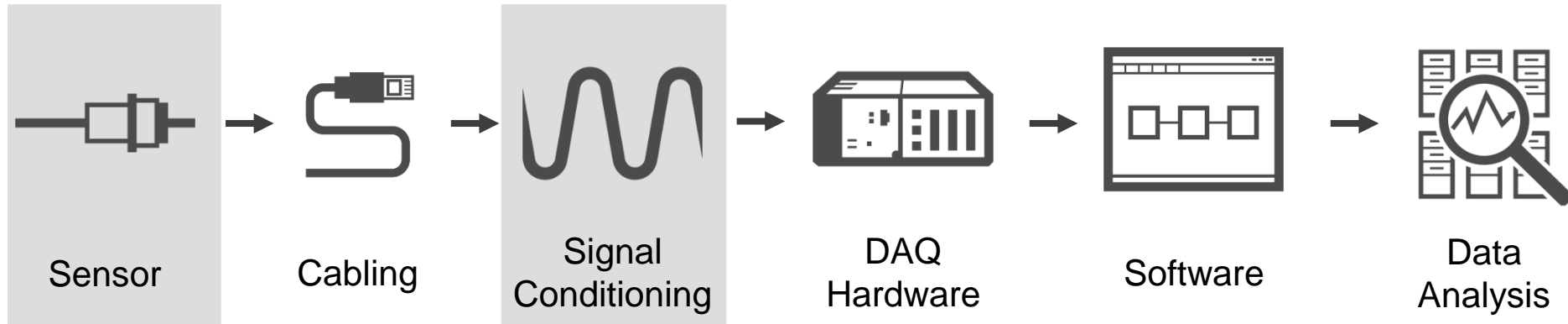


# Anti-Aliasing before Software Digital Filtering

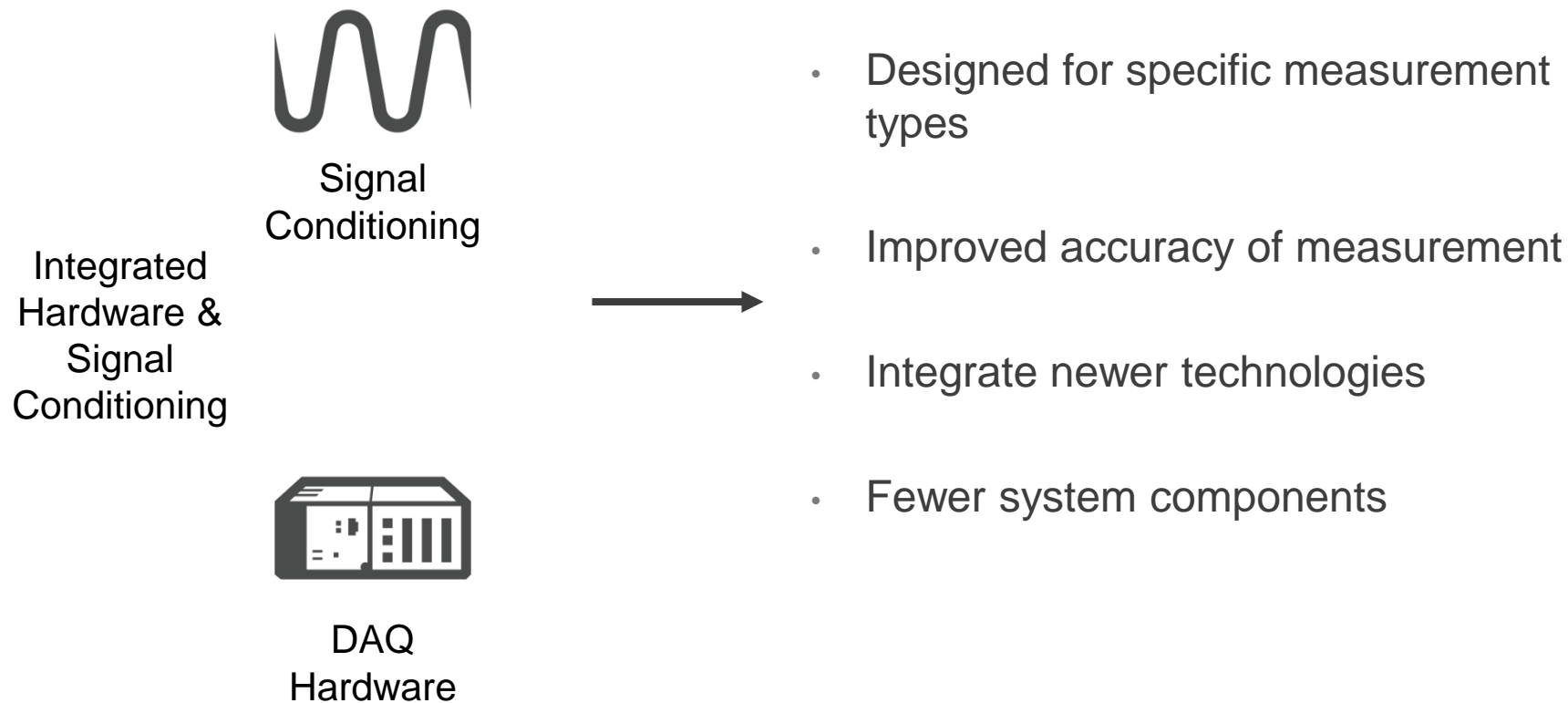
- Digital filtering of sampled data can have unexpected results
- Actual filter response is aliased as well
- Use hardware anti-aliasing filters to prevent aliasing of software filters



# Elements of a DAQ System



# Data Acquisition Hardware and Signal Conditioning



# Do You Need Signal Conditioning?

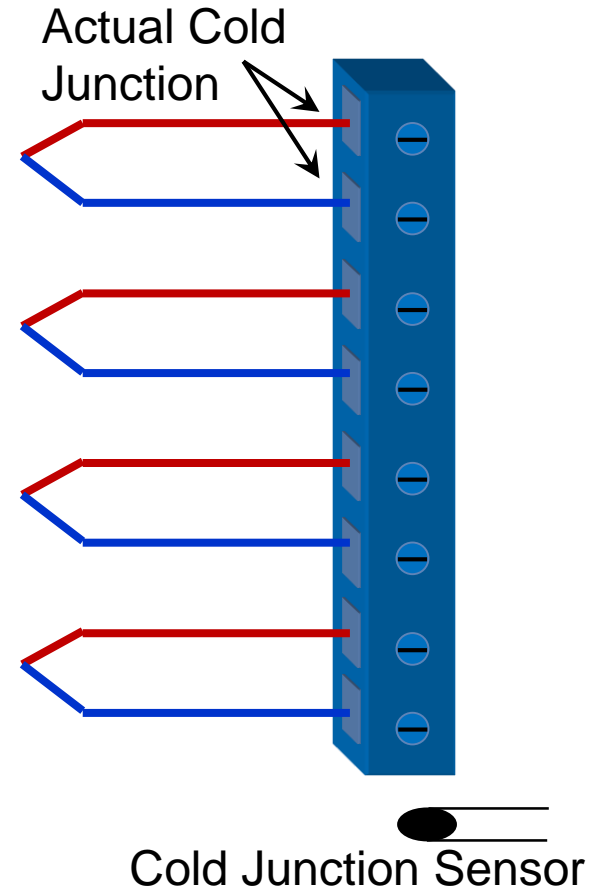
- There are many different types of signal conditioning
- You will need conditioning for certain sensor types
  - RTD
  - Thermocouple
  - Strain gage
  - Bridge sensors
  - Accelerometers
- You may need conditioning based on what you're measuring and the environment you are in
  - Amplification
  - Attenuation
  - Isolation
  - Filtering





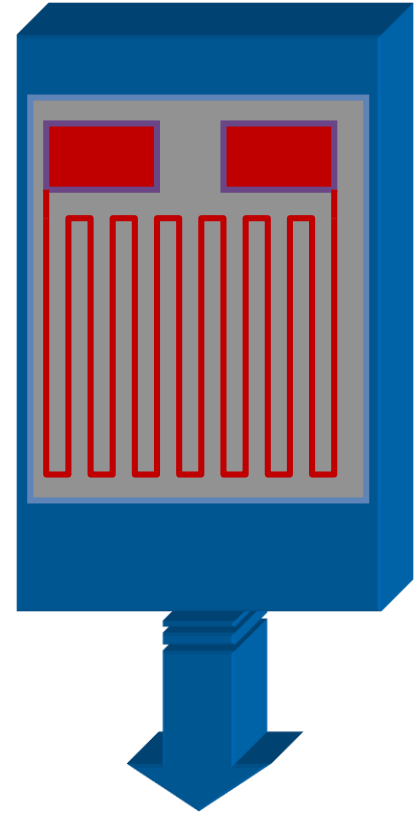
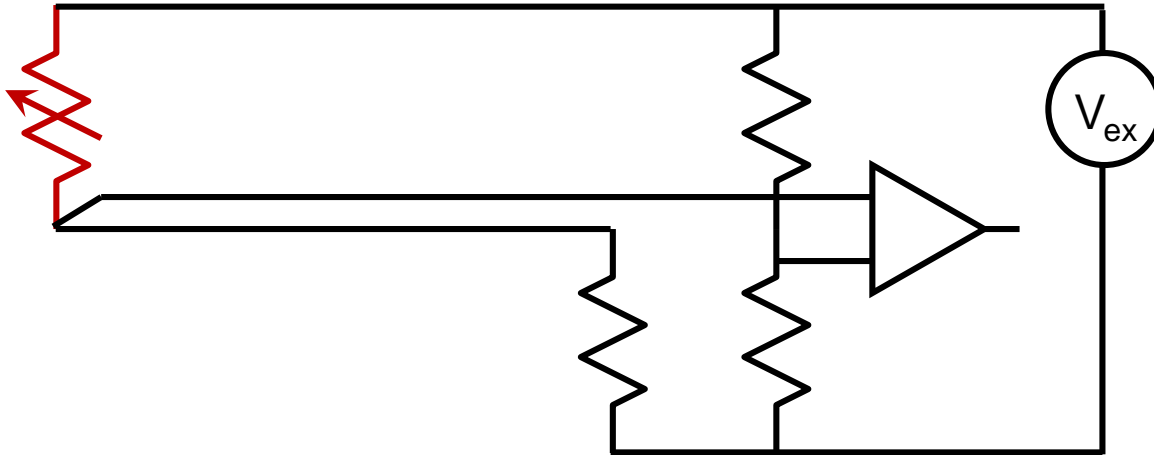
# Thermocouple Measurements

- Adjust for cold junction temperature
- Isothermal error:
  - Temperature difference between actual cold junction and cold junction sensor
- **Isothermal terminal blocks** designed to minimize temperature gradients
- Millivolt level signals- 10 to 60  $\mu\text{V}$  per  $^{\circ}\text{C}$
- Sensitive to noise pickup
- **50/60Hz comb filters** to reject powerline noise



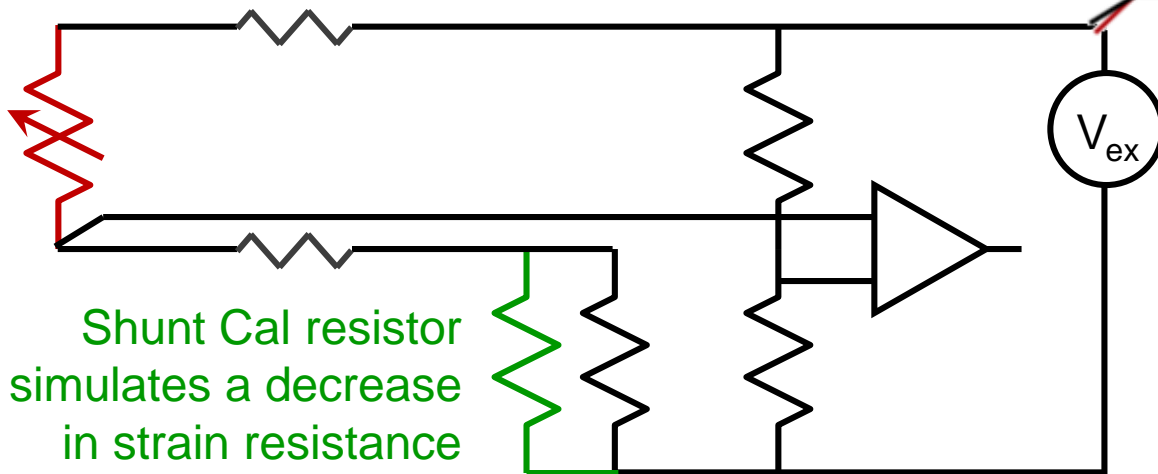
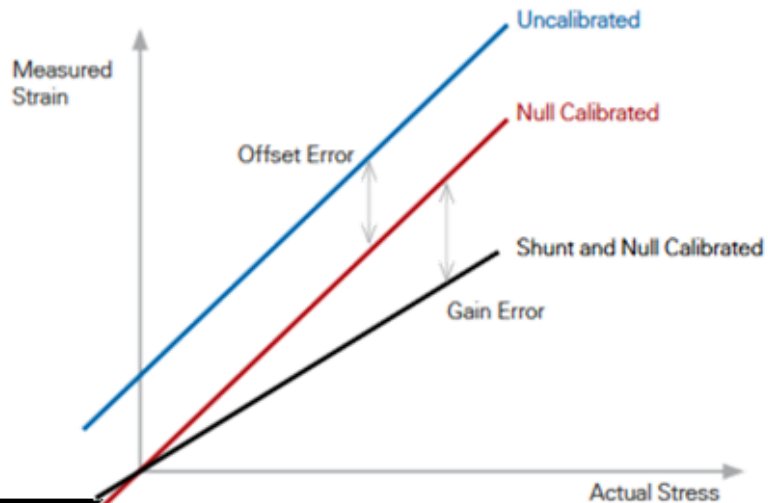
# Strain Gages

- Resistance changes with strain
- Sensitive to small ( $\sim 0.1$  milliohm) changes
- Measured with Wheatstone Bridges



# Strain Gages

- Cable resistance creates offset and gain errors
- **Offset nulling (Tare) adjusts offset error**
- **Shunt Calibration corrects for gain errors**



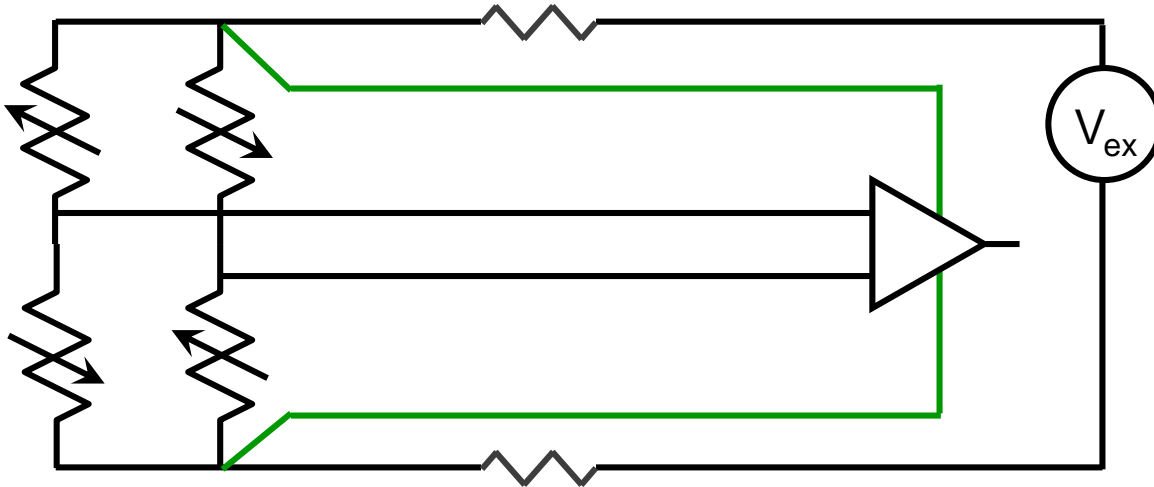
Shunt Cal resistor  
simulates a decrease  
in strain resistance

# Strain Gage based sensors

- Cable resistance creates gain errors
- **Remote Sense corrects for gain errors**
- Measure ratio of signal to excitation
- **National Instruments bridge modules directly measure ratiometrically**

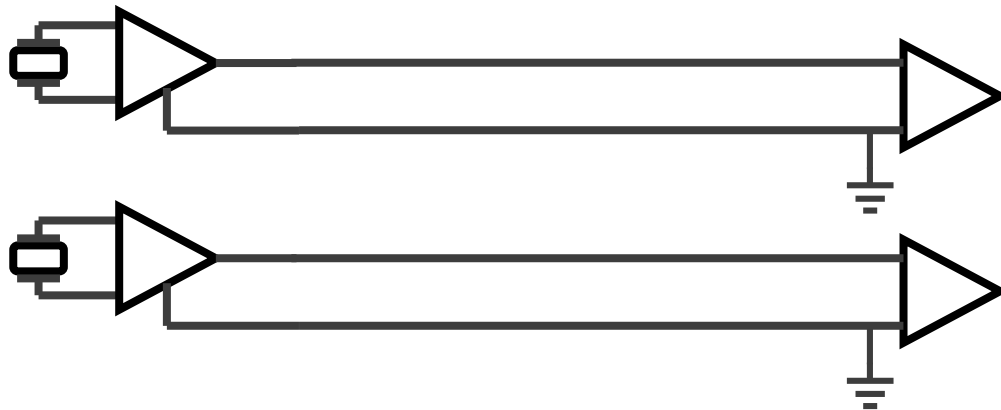


Load, Pressure,  
Force, Torque



# Single Ended Inputs

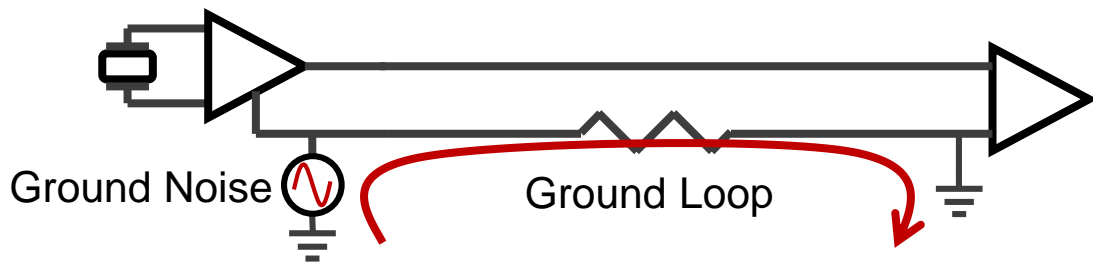
- Most suitable with floating Sensors
  - Provides a single connection to ground
  - Often provides lowest cost per channel



Floating (isolated) Sensors

# Single Ended Inputs and Ground Loops

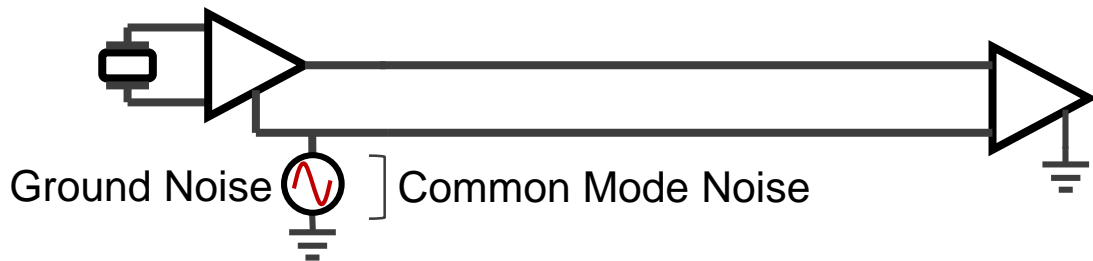
- Grounded Sensors with Single-ended Measurements
  - “Grounds” are never exactly the same
  - Create potential for Ground Loops
  - Create measurement errors in cabling
  - Better choice: use Differential Measurements



Grounded Sensor

# Differential Inputs to Break Ground Loops

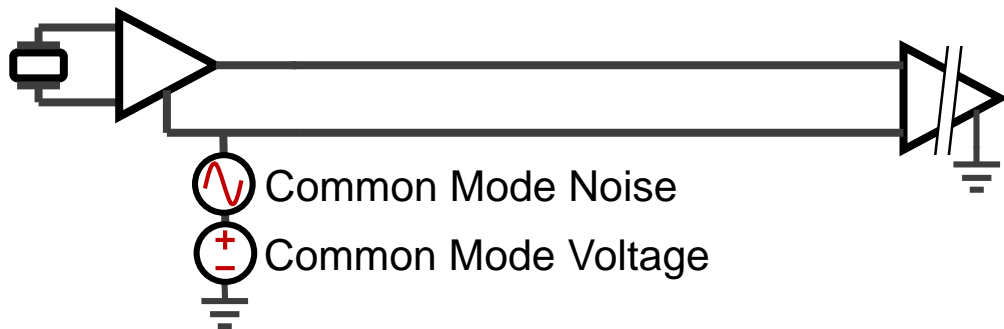
- High impedance of differential inputs break ground loops
  - Ground noise now becomes Common Mode noise
  - Rejected by Common Mode Rejection Ratio (CMRR) of measurement device
  - Limited to Common Mode Range of measurement device (e.g., 10 V)



Grounded Sensor

# Isolated Inputs

- Inputs isolated from ground provide higher common mode voltage range
  - Improved Common Mode Rejection Ratio (CMRR)
  - Typical common mode ranges are 60 Vdc or 250 Vac
  - Fault withstand levels can be thousands of volts
  - “Isolation” at National Instruments implies “Galvanic Isolation”- no conductive path

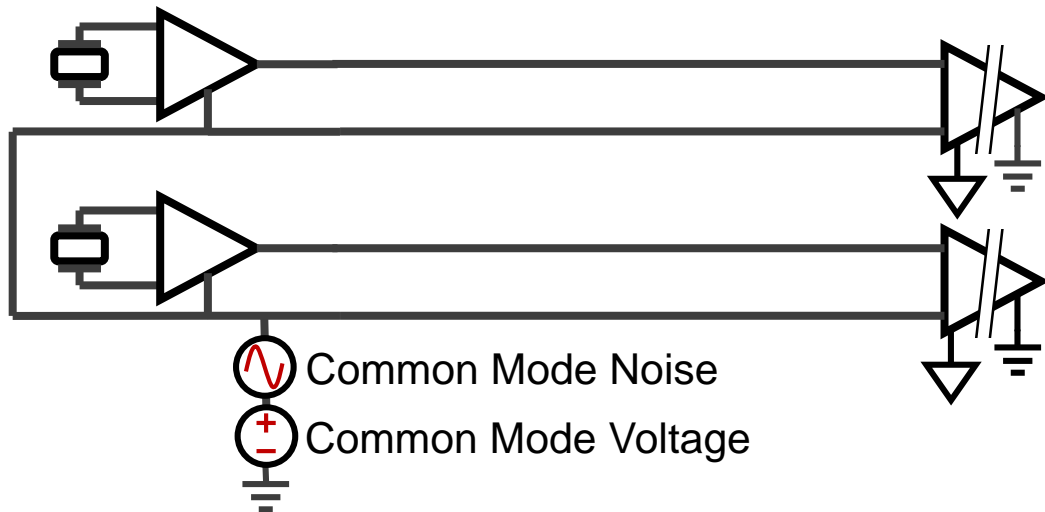


Ground Referenced Sensor



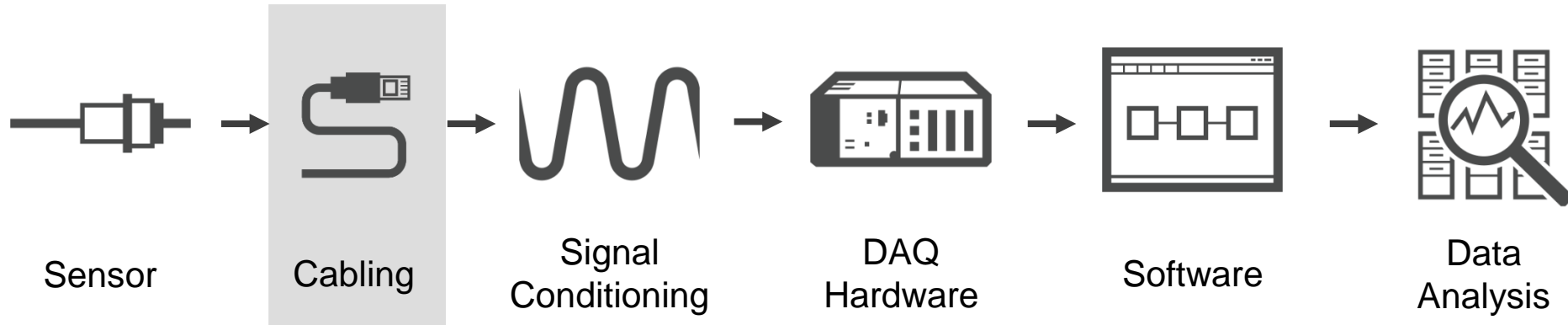
# Bank Isolated Inputs

- Multiple input channels, isolated from ground, but not each other
  - High common mode voltage and CMRR to Earth
  - Lower common mode voltage and CMRR to Isolated Ground



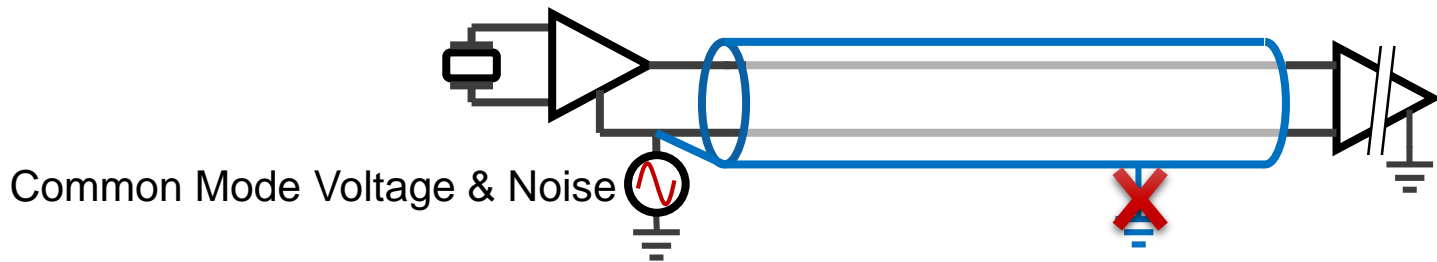
Ground Referenced Sensors

# Elements of a DAQ System



# Isolated Inputs

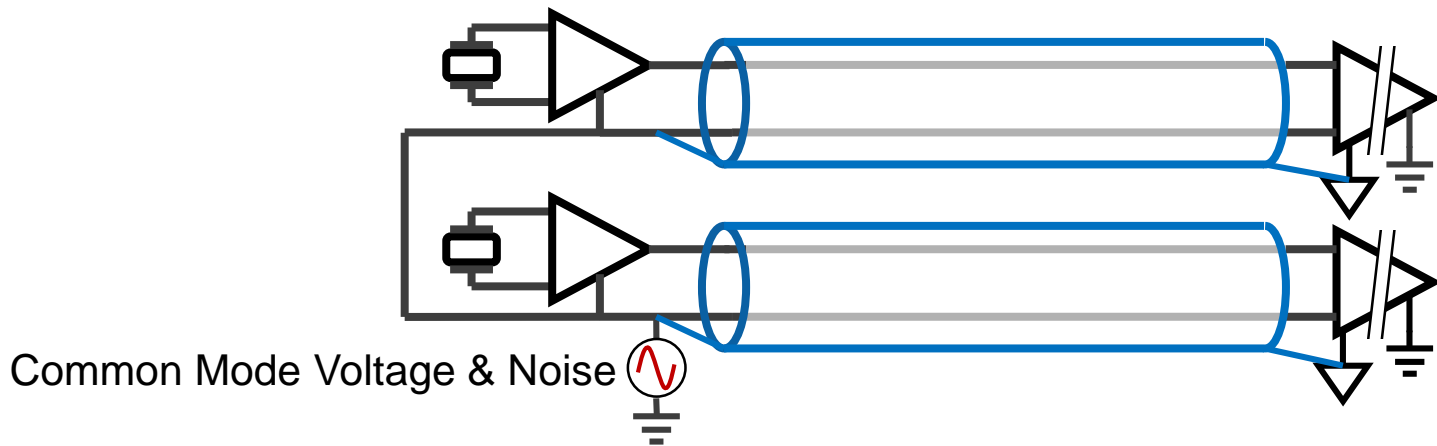
- When signal reference is noisy relative to Earth ground...
- Earth ground becomes a (relative) noise source!
- Connect shields to signal ground



Ground Referenced Sensor

# Bank Isolated Inputs

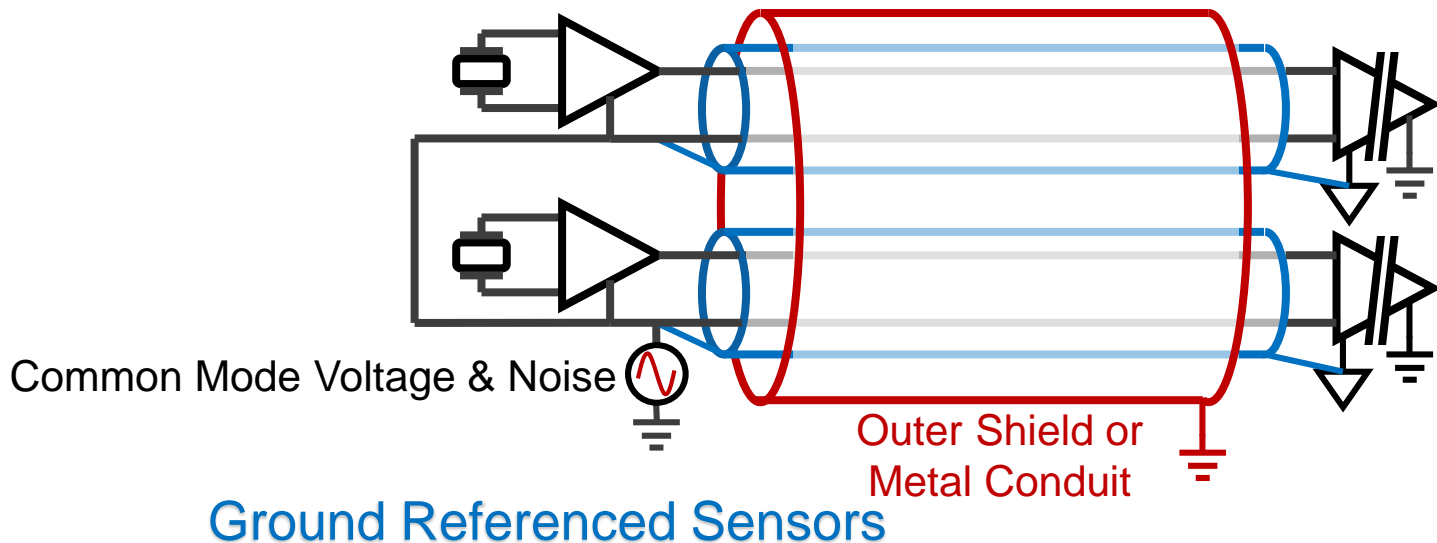
- Shields are still connected to the local signal reference
- Also connect Shield(s) to isolated measurement ground/common



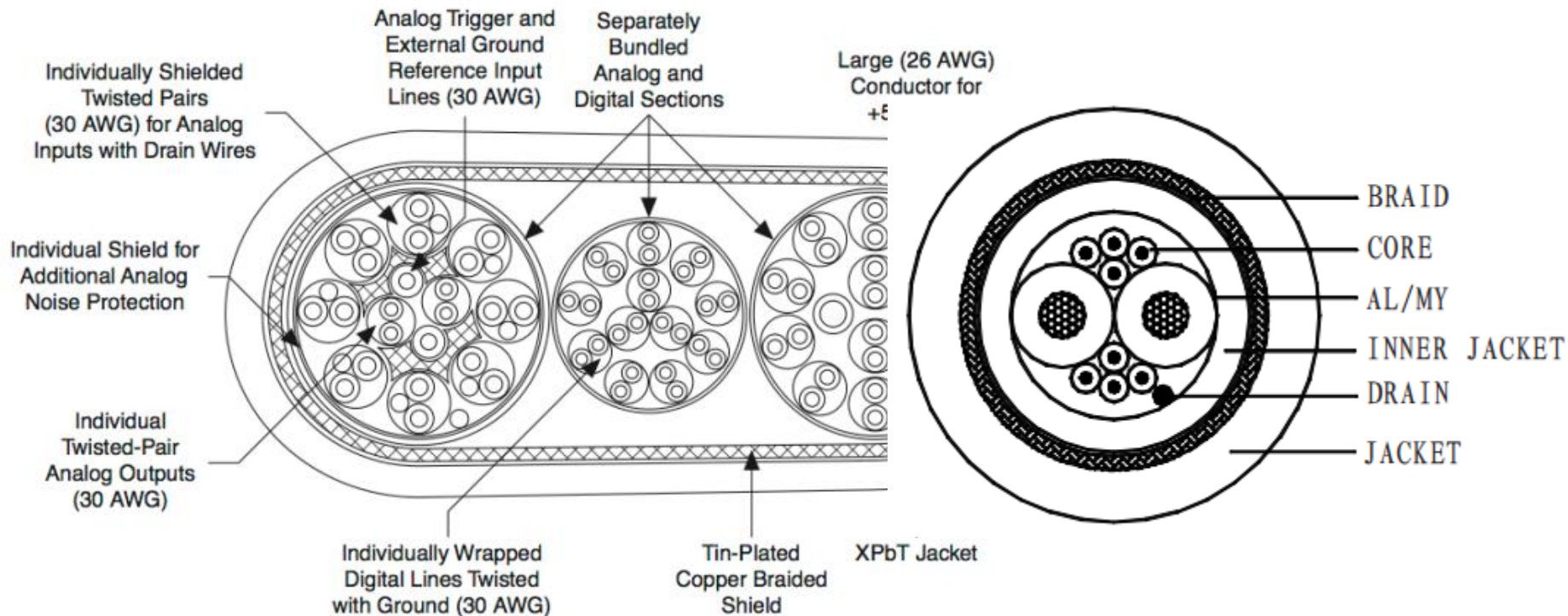
Ground Referenced Sensors

# Double-Shielded Cables

- Inner shield tied to measurement ground, outer shield tied to Earth ground
  - Inner shield protects signal pair(s)
  - Outer shield reduces common mode noise pickup
  - Outer shield blocks common mode noise emissions

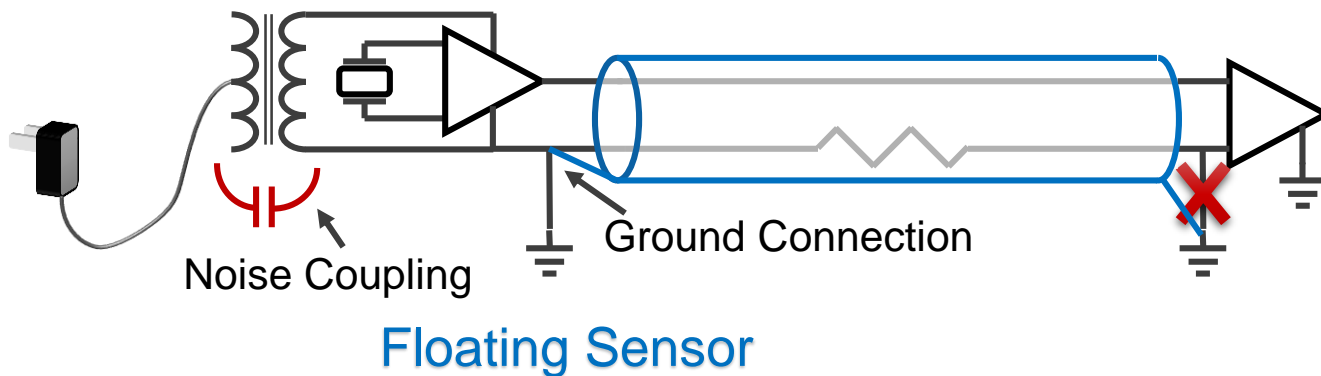


# Double-Shielded Cables



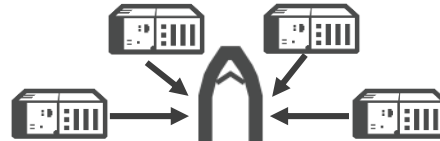
# Floating Sensors

- Isolated signal sources with no direct connection to ground
  - Pick up common mode noise easily
  - Make ONE connection to ground
  - Ground near most likely noise source
  - Connect shields to ground
    - Shield connection point is less important
    - Ground loops in shields are less concerning

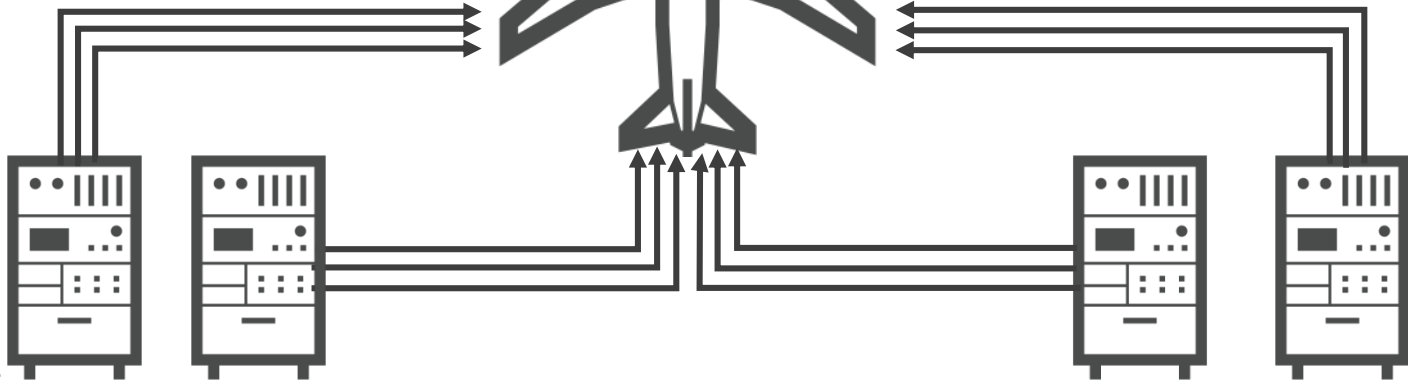


# Minimizing Sensor Cable Lengths

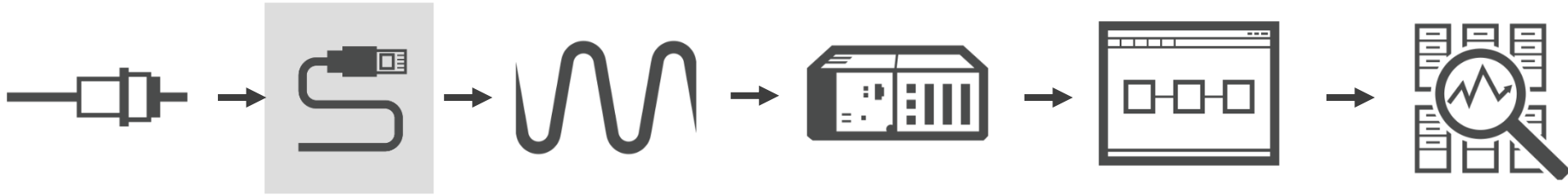
**CompactRIO  
CompactDAQ**



**PXI(e)  
PCI(e)**







## Key Things to Remember

- Signals should have one, and only one, reference connection to Earth ground
- Connect inner shields to this reference connection (the signal ground)
- Connect outer shields or conduit to Earth ground
- Place measurement devices closer to sensors to limit cable noise pickup

## Stay Connected



[ni.com/niweekcommunity](https://ni.com/niweekcommunity)



[facebook.com/NationalInstruments](https://facebook.com/NationalInstruments)



[twitter.com/niglobal](https://twitter.com/niglobal)



[youtube.com/nationalinstruments](https://youtube.com/nationalinstruments)